

INTERNATIONAL STANDARD

NORME INTERNATIONALE



**Fibre optic communication subsystem test procedures –
Part 2-2: Digital systems – Optical eye pattern, waveform and extinction ratio
measurement**

**Procédures d'essai des sous-systèmes de télécommunication fibroniques –
Partie 2-2: Systèmes numériques – Mesure du diagramme de l'œil optique,
de la forme d'onde et du taux d'extinction**



THIS PUBLICATION IS COPYRIGHT PROTECTED
Copyright © 2012 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

Droits de reproduction réservés. Sauf indication contraire, aucune partie de cette publication ne peut être reproduite ni utilisée sous quelque forme que ce soit et par aucun procédé, électronique ou mécanique, y compris la photocopie et les microfilms, sans l'accord écrit de l'IEC ou du Comité national de l'IEC du pays du demandeur. Si vous avez des questions sur le copyright de l'IEC ou si vous désirez obtenir des droits supplémentaires sur cette publication, utilisez les coordonnées ci-après ou contactez le Comité national de l'IEC de votre pays de résidence.

IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

IEC publications search - webstore.iec.ch/advsearchform

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee,...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: sales@iec.ch.

Electropedia - www.electropedia.org

The world's leading online dictionary on electrotechnology, containing more than 22 000 terminological entries in English and French, with equivalent terms in 16 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

IEC Glossary - std.iec.ch/glossary

67 000 electrotechnical terminology entries in English and French extracted from the Terms and Definitions clause of IEC publications issued since 2002. Some entries have been collected from earlier publications of IEC TC 37, 77, 86 and CISPR.

A propos de l'IEC

La Commission Electrotechnique Internationale (IEC) est la première organisation mondiale qui élabore et publie des Normes internationales pour tout ce qui a trait à l'électricité, à l'électronique et aux technologies apparentées.

A propos des publications IEC

Le contenu technique des publications IEC est constamment revu. Veuillez vous assurer que vous possédez l'édition la plus récente, un corrigendum ou amendement peut avoir été publié.

Recherche de publications IEC -

webstore.iec.ch/advsearchform

La recherche avancée permet de trouver des publications IEC en utilisant différents critères (numéro de référence, texte, comité d'études,...). Elle donne aussi des informations sur les projets et les publications remplacées ou retirées.

IEC Just Published - webstore.iec.ch/justpublished

Restez informé sur les nouvelles publications IEC. Just Published détaille les nouvelles publications parues. Disponible en ligne et une fois par mois par email.

Service Clients - webstore.iec.ch/csc

Si vous désirez nous donner des commentaires sur cette publication ou si vous avez des questions contactez-nous: sales@iec.ch.

Electropedia - www.electropedia.org

Le premier dictionnaire d'électrotechnologie en ligne au monde, avec plus de 22 000 articles terminologiques en anglais et en français, ainsi que les termes équivalents dans 16 langues additionnelles. Egalement appelé Vocabulaire Electrotechnique International (IEV) en ligne.

Glossaire IEC - std.iec.ch/glossary

67 000 entrées terminologiques électrotechniques, en anglais et en français, extraites des articles Termes et Définitions des publications IEC parues depuis 2002. Plus certaines entrées antérieures extraites des publications des CE 37, 77, 86 et CISPR de l'IEC.

INTERNATIONAL STANDARD

NORME INTERNATIONALE



**Fibre optic communication subsystem test procedures –
Part 2-2: Digital systems – Optical eye pattern, waveform and extinction ratio
measurement**

**Procédures d'essai des sous-systèmes de télécommunication fibroniques –
Partie 2-2: Systèmes numériques – Mesure du diagramme de l'œil optique,
de la forme d'onde et du taux d'extinction**

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

COMMISSION
ELECTROTECHNIQUE
INTERNATIONALE

ICS 33.180.01

ISBN 978-2-8322-8794-1

**Warning! Make sure that you obtained this publication from an authorized distributor.
Attention! Veuillez vous assurer que vous avez obtenu cette publication via un distributeur agréé.**

CONTENTS

FOREWORD.....	4
1 Scope.....	6
2 Normative references	6
3 Terms and definitions	6
4 Apparatus.....	7
4.1 General	7
4.2 Reference receiver definition.....	8
4.3 Time-domain optical detection system	8
4.3.1 Overview	8
4.3.2 Optical-to-electrical (O/E) converter.....	8
4.3.3 Linear-phase low-pass filter.....	9
4.3.4 Oscilloscope.....	9
4.4 Overall system response	10
4.5 Oscilloscope synchronization system.....	11
4.5.1 General	11
4.5.2 Triggering with a clean clock	11
4.5.3 Triggering using a recovered clock	12
4.5.4 Triggering directly on data	13
4.6 Pattern generator	13
4.7 Optical power meter	13
4.8 Optical attenuator.....	13
4.9 Test cord.....	13
5 Signal under test	14
6 Instrument set-up and device under test set-up	14
7 Measurement procedures	15
7.1 Overview	15
7.2 Extinction ratio measurement	15
7.2.1 Configure the test equipment.....	15
7.2.2 Measurement procedure	15
7.2.3 Extinction ratio calculation	16
7.3 Eye amplitude	17
7.4 Optical modulation amplitude (OMA) measurement using the square wave method.....	17
7.4.1 General	17
7.4.2 Oscilloscope triggering	17
7.4.3 Amplitude histogram, step 1	17
7.4.4 Amplitude histogram, step 2	17
7.4.5 Calculate OMA	17
7.5 Contrast ratio (for RZ signals)	18
7.6 Jitter measurements	18
7.7 Eye width	19
7.8 Duty cycle distortion (DCD)	19
7.9 Crossing percentage	20
7.10 Eye height.....	21
7.11 Q-factor/signal-to-noise ratio (SNR).....	21
7.12 Rise time.....	21

- 7.13 Fall time 22
- 8 Eye-diagram analysis using a mask 23
 - 8.1 Eye mask testing using the 'no hits' technique 23
 - 8.2 Eye mask testing using the 'hit-ratio' technique 24
- 9 Test result 26
 - 9.1 Required information 26
 - 9.2 Available information 26
 - 9.3 Specification information 26
- Bibliography 27

- Figure 1 – Optical eye pattern, waveform and extinction ratio measurement configuration 8
- Figure 2 – Oscilloscope bandwidths commonly used in eye pattern measurements 10
- Figure 3 – PLL jitter transfer function and resulting observed jitter transfer function 12
- Figure 4 – Histograms centred in the central 20 % of the eye used to determine the mean logic one and 0 levels, b_1 and b_0 16
- Figure 5 – OMA measurement using the square wave method 18
- Figure 6 – Construction of the duty cycle distortion measurement 20
- Figure 7 – Construction of the crossing percentage measurement 21
- Figure 8 – Construction of the risetime measurement with no reference receiver filtering 22
- Figure 9 – Illustrations of several RZ eye-diagram parameters 23
- Figure 10 – Basic eye mask and coordinate system 24
- Figure 11 – Mask margins at different sample population sizes 26
- Table 1 – Frequency response characteristics 11

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**FIBRE OPTIC COMMUNICATION SUBSYSTEM
TEST PROCEDURES –****Part 2-2: Digital systems – Optical eye pattern,
waveform and extinction ratio measurement**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61280-2-2 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

This fourth edition cancels and replaces the third edition published in 2008 and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) additional definitions;
- b) clarification of test procedures.

The text of this standard is based on the following documents:

CDV	Report on voting
86C/1043/CDV	86C/1074/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61280 series, published under the general title *Fibre optic communication subsystem test procedures*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

The contents of the corrigendum of February 2015 have been included in this copy.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES –

Part 2-2: Digital systems – Optical eye pattern, waveform and extinction ratio measurement

1 Scope

The purpose of this part of IEC 61280 is to describe a test procedure to verify compliance with a predetermined waveform mask and to measure the eye pattern and waveform parameters such as rise time, fall time, modulation amplitude and extinction ratio.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61280-2-3, *Fibre optic communication subsystem test procedures – Part 2-3: Digital systems – Jitter and wander measurements*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1

amplitude histogram

graphical means to display the power or voltage population distribution of a waveform

3.2

contrast ratio

ratio of the nominal peak amplitude to the nominal minimum amplitude of two adjacent logical '1's when using return-to-zero transmission

3.3

duty cycle distortion

DCD

measure of the balance of the time width of a logical 1 bit to the width of a logical 0 bit, indicated by the time between the eye diagram nominal rising edge at the average or 50 % level and the eye diagram nominal falling edge at the average or 50 % level

3.4

extinction ratio

ratio of the nominal 1 level to the nominal 0 level of the eye diagram

3.5

eye diagram

type of waveform display that exhibits the overall performance of a digital signal by superimposing all the acquired samples on a common time axis one unit interval in width